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**NTE74LS114**  
**Integrated Circuit**  
**TTL – Dual J-K Negative Edge Triggered Flip-Flop**  
**with Preset, Common Clear, and Common Clock**

**Description:**

The NTE74LS114 contains two independent J-K negative-edge-triggered flip-flops in a 14-Lead plastic DIP type package. A low level at the preset and clear inputs sets or resets the outputs regardless of the levels of the other inputs. When preset and clear are inactive (high), data at the J and K inputs meeting the setup time requirements are transferred to the outputs on the negative-going edge of the clock pulse. Clock triggering occurs at a voltage level and is not directly related to the rise time of the clock pulse. Following the hold time interval, data at the J and K inputs may be changed without affecting the levels at the outputs. This versatile flip-flop can perform as a toggle flip-flop by tying J and K high.

**Features:**

- Fully Buffered to offer Maximum Isolation from External Disturbance

**Absolute Maximum Ratings:** (Note 1)

Supply Voltage, $V_{CC}$ .....	7V
DC Input Voltage, $V_{IN}$ .....	7V
Operating Temperature Range, $T_A$ .....	0°C to +70°C
Storage Temperature Range, $T_{stg}$ .....	-65°C to +150°C

Note 1. Unless otherwise specified, all voltages are referenced to GND.

**Recommended Operating Conditions:**

Parameter	Symbol	Min	Typ	Max	Unit
Supply Voltage	$V_{CC}$	4.75	5.0	5.25	V
High-Level Input Voltage	$V_{IH}$	2.0	–	–	V
Low-Level Input Voltage	$V_{IL}$	–	–	0.8	V
High-Level Output Current	$I_{OH}$	–	–	-0.4	mA
Low-Level Output Current	$I_{OL}$	–	–	8	mA
Clock Frequency	$f_{clock}$	0	–	30	MHz
Pulse Duration CLK	$t_w$	20	–	–	ns
$\overline{PRE}$ or $\overline{CLR}$ Low		25	–	–	ns
Setup Time before CLK↓ Data High or Low	$t_w$	20	–	–	ns
$\overline{CLR}$ Inactive		25	–	–	ns
$\overline{PRE}$ Inactive		20	–	–	ns
Hold Time Data after CLK↓	$t_h$	0	–	–	ns
Operating Temperature Range	$T_A$	0	–	+70	°C

## Electrical Characteristics: (Note 2, Note 3)

Parameter	Symbol	Test Conditions	Min	Typ	Max	Unit
Input Clamp Voltage	$V_{IK}$	$V_{CC} = \text{MIN}$ , $I_I = -18\text{mA}$	-	-	-1.5	V
High Level Output Voltage	$V_{OH}$	$V_{CC} = \text{MIN}$ , $V_{IH} = 2\text{V}$ , $V_{IL} = \text{MAX}$ , $I_{OH} = -0.4\text{mA}$	2.7	3.4	-	V
Low Level Output Voltage	$V_{OL}$	$V_{CC} = \text{MIN}$ , $V_{IH} = 2\text{V}$ , $V_{IL} = \text{MAX}$ , $I_{OL} = 4\text{mA}$	-	0.25	0.4	V
		$V_{CC} = \text{MIN}$ , $V_{IH} = 2\text{V}$ , $V_{IL} = \text{MAX}$ , $I_{OL} = 8\text{mA}$	-	0.35	0.5	V
Input Current J or K	$I_I$	$V_{CC} = \text{MAX}$ , $V_I = 7\text{V}$	-	-	0.1	mA
$\overline{\text{CLR}}$			-	-	0.6	mA
$\overline{\text{PRE}}$			-	-	0.3	mA
$\overline{\text{CLK}}$			-	-	0.8	mA
High Level Input Current J or K	$I_{IH}$	$V_{CC} = \text{MAX}$ , $V_I = 2.7\text{V}$	-	-	20	$\mu\text{A}$
$\overline{\text{CLR}}$			-	-	120	$\mu\text{A}$
$\overline{\text{PRE}}$			-	-	60	$\mu\text{A}$
$\overline{\text{CLK}}$			-	-	160	$\mu\text{A}$
Low Level Input Current J or K	$I_{IL}$	$V_{CC} = \text{MAX}$ , $V_I = 0.4\text{V}$	-	-	-0.4	mA
$\overline{\text{CLR}}$			-	-	-1.6	mA
$\overline{\text{PRE}}$			-	-	-0.8	mA
$\overline{\text{CLK}}$			-	-	-1.6	mA
Short-Circuit Output Current	$I_{OS}$	$V_{CC} = \text{MAX}$ , Note 4	-20	-	-100	mA
Supply Current	$I_{CC}$	$V_{CC} = \text{MAX}$ , Note 5	-	4	6	mA

Note 2. For conditions shown as MIN or MAX, use the appropriate value specified under "Recommended Operation Conditions".

Note 3. All typical values are at  $V_{CC} = 5\text{V}$ ,  $T_A = +25^\circ\text{C}$ .

Note 4. For certain devices where state commutation can be caused by shorting an output to GND, an equivalent test may be performed with  $V_O = 2.125\text{V}$  and the minimum and maximum limits reduced to one half of their stated values.

Note 5. With all outputs open,  $I_{CC}$  is measured with the Q and  $\overline{Q}$  outputs high in turn. At the time of measurement, the clock input is grounded.

## Switching Characteristics: ( $V_{CC} = 5\text{V}$ , $T_A = +25^\circ\text{C}$ unless otherwise specified)

Parameter	Symbol	Test Conditions	Min	Typ	Max	Unit
Maximum Clock Frequency	$t_{max}$	$R_L = 2\text{k}\Omega$ , $C_L = 15\text{pF}$	30	45	-	MHz
Propagation Delay Time From $\overline{\text{PRE}}$ or $\overline{\text{CLR}}$ Input to Q or $\overline{Q}$ Output	$t_{PLH}$ , $t_{PHL}$		-	15	20	ns

Function Table (Each Flip-Flop):

Inputs					Outputs	
$\overline{\text{PRE}}$	$\overline{\text{CLR}}$	$\overline{\text{CLK}}$	J	K	Q	$\overline{Q}$
L	H	X	X	X	H	L
H	L	X	X	X	L	H
L	L	X	X	X	H†	H†
H	H	↓	L	L	$Q_0$	$\overline{Q}_0$
H	H	↓	H	L	H	L
H	H	↓	L	H	L	H
H	H	↓	H	H	Toggle	
H	H	H	X	X	$Q_0$	$\overline{Q}_0$

† The output levels in this configuration are not guaranteed to meet the minimum levels for  $V_{OH}$  if the lows at preset and clear are near  $V_{IL}$  maximum. Furthermore, this configuration is nonstable; that is, it will not persist when preset or clear return to their inactive (high) level.

**Pin Connection Diagram**

